Probes and accessories Rohde & Schwarz digital oscilloscopes Product Brochure | Version 10.00

Digital oscilloscopes from Rohde & Schwarz Probes and accessories At a glance

Test applications for oscilloscopes range from debugging complex electronic circuits to measuring the signal integrity of high-speed bus signals and characterizing power electronics with dangerous voltage levels. Measurement accuracy and operator safety depend on the probes and accessories that are used.

Rohde & Schwarz passive probes are the perfect accessory for general measurement applications involving low-frequency signals. The very fine, spring-loaded tip allows precise and reliable contacting of signal lines.

Active broadband probes are ideal for applications where low loading on the DUT is crucial or when the measured signal contains high-frequency signal components. Rohde & Schwarz broadband probes feature a very low load and a wide dynamic range. The integrated, high-precision DC voltmeter permits fast and easy testing (both differential and single-ended) of DC voltage levels on signal lines, irrespective of the oscilloscope settings. The configurable, integrated micro button makes it easy to operate the oscilloscope when measuring with multiple probes. An extensive range of probe accessories ensures optimal contacting.

Operator safety is the highest priority during measurements on power electronics. Rohde & Schwarz offers high-voltage probes and current probes for measurements up to CAT III.

EMC near-field probes open a new application field for oscilloscopes. High sensitivity and the powerful spectrum analysis function make the R&S®RTO digital oscilloscopes a valuable tool for analyzing EMC problems when used in conjunction with near-field probes.

Key facts

- Probes for every application: differential or singleended voltage measurements, current measurements, EMC near-field measurements
- . Active probes with very low load due to high input impedance of up to 1 M Ω || 0.3 pF and wide dynamic range of ±8 V
- Modular broadband probes with low capacitive loading and flexible and configurable connectivity
- R&S®ProbeMeter: integrated voltmeter with 0.1% measurement uncertainty for precise DC measurements
- I Simple operation using the configurable micro button
- Comprehensive accessories for maximum flexibility during contacting
- Passive probes included with every Rohde & Schwarz oscilloscope

Models



Passive probes

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Modular broadband probes

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High-voltage probes
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EMC near-field probes page 26

Selecting the right probe

The first step in selecting the right probe is to analyze the measurement task. Is a single-ended or a differential measurement needed? Which maximum frequency components need to be transferred? What is the maximum input voltage that can occur?

Differential or single-ended measurement

Differential probes make measurements possible when neither of the two test points is connected to ground. An example is voltage measurements on components without a connection to ground, which is necessary when characterizing switching power supplies. Differential probes are also needed for low-noise measurements on differential signals.

Differential probes can in fact also be used for singleended measurements. Single-ended probes often offer a higher input impedance, a lower input capacitance and the advantage of a wider dynamic range.

Bandwidth and rise time

Bandwidth is one of the most important parameters when selecting a probe. It defines the cutoff frequency after which a signal will be displayed more than 3 dB (approx. 30%) weaker than it actually is. For an accurate signal representation, the cutoff frequency of the measurement system (oscilloscope and probe) must be greater than the highest frequency component to be displayed. When measuring digital signals, the measurement bandwidth should be 3 to 5 times greater than the clock rate (For debugging a digital design, a bandwidth that is 3 times greater is sufficient. For conformance tests on digital interfaces, the bandwidth must be 5 times greater than the clock rate.).

When measuring fast slopes, such as when characterizing switching power supplies, the critical parameter is the rise time of the measurement system (oscilloscope and probe). For precise measurements, the rise time of the measurement system should be a factor of 3 to 5 times lower than the rise time of the pulse being measured.

Dynamic range

The dynamic range of a probe is defined as the maximum measurable input voltage. It is specified for DC voltage and often decreases as the frequency increases. In the case of differential probes, a distinction is also made between common mode and differential mode dynamic range. The common mode dynamic range determines the valid input voltage range for a single differential input, measured with reference to ground. The differential mode dynamic range defines the maximum measurable input differential voltage.

To accurately measure steep, large-amplitude slopes, a sufficiently wide dynamic range must be available at high frequencies. When measuring the residual ripple of DC switching power supplies, very small signals with a large DC component must also be measured. To make the full A/D converter resolution available, modern probes have the option to feed in a DC offset.

In the case of high-voltage probes, operator safety is a key consideration. High-voltage probes therefore have special insulation, protection against accidental contact and other protective mechanisms. These probes are characterized by the maximum voltage to ground and by the measurement category. The measurement category defines the measurement environments in which the operator is still protected. A probe may only be used in the measurement categories for which it is defined.

Load on the device under test

A measurement system must not excessively load the circuit under test, both to prevent degraded signals and to ensure that the functioning of the DUT is not impaired. The key is to use probes with a high input impedance and a low input capacitance. The resulting input impedance is highly dependent on the frequency and is typically less than 500 Ω at the probe's cutoff frequency.

Passive probes typically have an input impedance of $10~M\Omega$ and an input capacitance of > 10~pF. Active probes typically have an input capacitance of < 1~pF at an input impedance of $1~M\Omega$ and are especially suited for measurements on circuits with high-speed signals > 100~MHz. For the measurement, it is important to select the right probe accessories for contacting with the DUT. Long pins and leads increase the capacitance and inductance, lower the maximum measurement bandwidth and lead to excessive overshoot and ringing artifacts at the pulse slopes.

Expanded functions and probe accessories

Usable

In addition to the performance parameters, the supplemental functions for simplifying daily tasks must be considered. Examples include an integrated digital voltmeter or a micro button. The functionality of the micro button can be configured to allow direct control of the oscilloscope from the probe.

The diverse accessories offer flexibility during test point contacting, make the operator's day-to-day work easier and help to prevent measurement errors. Available accessories include rigid and spring-loaded tips, browsers, adapters and extension leads. Rohde & Schwarz offers a comprehensive set of accessories for every probe.

| | | Oscillosco | ope family | | | |
|----------------------------------|---------------------------------|------------|---------------------|---------|---------|---------|
| | Interface | R&S®RTH | R&S®HMO/ R&S®RTB | R&S®RTM | R&S®RTE | R&S®RTO |
| Passive probes | | | | | | |
| → page 6 | | | | | | |
| R&S®RT-ZP1X | BNC | | | | | |
| R&S®RT-ZI10/10C/11 | BNC | | | | | |
| R&S®RT-ZP03/ZP05 | BNC | | | | | |
| R&S®RTM-ZP10 | BNC | | | | | |
| R&S®RT-ZP10 | BNC | | | | | |
| Passive broadband probes | | | | | | |
| ▶ page 7 R&S°RT-ZZ80 | SMA/BNC | | | | | |
| Active broadband probes | SIVII V DI VO | | | | | |
| > page 8 | | | | | | |
| R&S®RT-ZS10L | BNC | | | | | |
| R&S®RT-ZS10E/10/20/30/60 | Rohde & Schwarz probe interface | | | | | |
| R&S®RT-ZD10/20/30/40 | Rohde&Schwarz probe interface | | | | | |
| Modular broadband probes | | | | | | |
| > page 14 | Dalada 9 Cala | | | | | |
| R&S°RT-ZM15/30/60/90 | Rohde & Schwarz probe interface | | | | | |
| Power rail probe ⊳ page 16 | | | | | | |
| R&S®RT-ZPR20 | Rohde & Schwarz probe interface | | | | | |
| Multi-channel power probe | | | | | | |
| R&S®RT-ZVC02/-ZVC04 | R&S®RTE/R&S®RTO MSO interface | | | | | |
| High-voltage probes ▷ page 22 | | | | | | |
| R&S®RT-ZH03/10/11 | BNC | | | | | |
| R&S®RT-ZD01/02/08 | BNC | | | | | |
| Current probes ⊳ page 24 | | | | | | |
| R&S®RT-ZC02/03 | BNC | | | | | |
| R&S®RT-ZC10/20/30 | BNC | | | | | |
| R&S*RT-ZC05B/10B/15B/20B | Rohde & Schwarz probe interface | | | | | |
| EMC near-field probes ⊳ page 26 | | | | | | |
| R&S®HZ-15 | BNC | | | | | |

Passive probes

Passive probes are standard accessories for Rohde & Schwarz oscilloscopes. They automatically detect the attenuation factor, and their springloaded tips make them precise to use.



Extensive R&S®RT-ZA1 accessory set for optimal contacting.



R&S®RT-ZA4 mini clips and R&S®RT-ZA5 micro clips for reliable contacting, especially when using multiple probes.



Universal application

Rohde & Schwarz passive probes are the all-rounders in the world of probes. With an input impedance of $10~M\Omega$, an input capacitance of 9.5~pF and a maximum input voltage of 400~V (RMS), they are ideal for measurements on low-frequency signals up to 100~MHz. The BNC connector allows them to be used on almost any oscilloscope. A code pin on the BNC connector enables Rohde & Schwarz oscilloscopes to automatically detect the attenuation factor. The fine, spring-loaded tip ensures good contact with the DUT.

Individual adjustment for precise measurements

In order to achieve optimum measurement accuracy at the cutoff frequency, passive probes must be adjusted to the input impedance of the oscilloscope. Rohde & Schwarz offers the R&S®RTM-ZP10 probe for the R&S®RTM digital oscilloscope and the R&S®RT-ZP10 probe for the R&S®RTO digital oscilloscope. Whenever a probe is connected to a different oscilloscope input, a capacitance trimmer in the BNC connector must be used to adjust the probe to the specific oscilloscope input.

Extensive accessories

For optimal contacting, Rohde & Schwarz offers the R&S®RT-ZA1 accessory set for passive probes. It includes spare spring-loaded tips, rigid tips, ground contact springs, ground leads and color-coded rings.

| Model | Bandwidth | Attenuation factor | Input impedance | Dynamic range | Comment | Order No. |
|--------------|-----------|--------------------|--------------------|--------------------------------------|--|--------------|
| Probes | | | | | | |
| R&S®RT-ZP1X | 38 MHz | 1:1 | 1 MΩ 39 pF | 55 V (RMS) (CAT II) | | 1333.1370.02 |
| R&S®RT-ZP03 | 300 MHz | 10:1/1:1 | 10 ΜΩ/1 ΜΩ | 400 V (RMS)/55 V (RMS) | no probe detection | 3622.2817.02 |
| R&S®RT-ZP05 | 500 MHz | 10:1 | 10 ΜΩ | 300 V (RMS) | | 3623.2927.02 |
| R&S®RTM-ZP10 | 500 MHz | 10:1 | 10 MΩ 9.5 pF | 400 V (RMS), 300 V (RMS) (CAT II) | 2.5 mm tip diameter, pre-adjusted for R&S®RTM | 1409.7550.00 |
| R&S®RT-ZP10 | 500 MHz | 10:1 | 10 MΩ 9.5 pF | 400 V (RMS), 300 V (RMS) (CAT II) | 2.5 mm tip diameter, pre-adjusted for R&S®RTO | 1409.7708.02 |
| Accessories | | | | | | |
| R&S®RT-ZA1 | | | | | accessory set for R&S°RTM-ZP10/R&S°RT-ZP10 | 1409.7566.02 |
| R&S®RT-ZA4 | | | | | mini clips | 1416.0428.02 |
| R&S®RT-ZA5 | | | | | micro clips | 1416.0434.02 |
| R&S®RT-ZA6 | | | | | lead set | 1416.0440.02 |

Passive broadband probes

Low noise, high linearity and a purely passive implementation make passive broadband probes an economical solution for measuring controlled impedance lines. The compact design facilitates measurements on densely packed printed boards.

Passive broadband probes: powerful alternative for measurements on controlled impedance



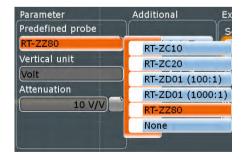
Economical alternative for measurements on controlled impedance lines

Passive broadband probes are an economical, yet powerful alternative to active probes for measuring high-speed signals on low impedance lines. In contrast to active probes, their input impedance is low but remains practically constant over the entire frequency range. They feature an extremely low input capacitance and particularly low noise. Their purely passive implementation renders them highly linear and therefore ideal for spectrum analysis applications.

The R&S°RT-ZZ80 8 GHz probe provides an attenuation factor of 10:1 at an input impedance of 500 Ω || 0.3 pF. Its SMA plug is connected to the oscilloscope via the provided SMA-BNC adapter. The probe can be easily selected as a predefined probe from the R&S°RTO digital oscilloscope menu. And with these simple steps, the instrument is correctly configured.

Maximum bandwidth through customized accessories

The maximum probe bandwidth is typically defined by the accessories that are used. Rohde & Schwarz supplies accessories tailored to both the probe and the application to ensure that the maximum bandwidth is available for various contacting methods. The extensive standard accessories for the R&S®RT-ZZ80 include solder-in pins, rigid tips, solder-in ground pins, spring-loaded ground tips and adapters for pin connectors. Because all probe tips have the same design, the R&S®RT-ZZ80 accessories are compatible with both single-ended and differential active probes (R&S®RT-ZS60 and R&S®RT-ZD40).



Selecting predefined probes with SMA or BNC connector on the R&S*RTO.

| Model | Bandwidth | Attenuation factor | Input impedance | Dynamic range | Comment | Order No. |
|-------------|-----------|--------------------|-----------------|-------------------------------------|--------------------------|--------------|
| Probes | | | | | | |
| R&S®RT-ZZ80 | 8 GHz | 10:1 | 500 Ω 0.3 pF | 20 V (RMS) max. input voltage | SMA-BNC adapter included | 1409.7608.02 |

Active broadband probes

Rohde & Schwarz offers an extensive range of active broadband probes with high input impedance of 1 M Ω , low input capacitance of < 1 pF and a wide dynamic range. Useful supplemental functions, such as offset compensation in the probe, an integrated, high-precision voltmeter and a micro button for convenient control of the oscilloscope, set these probes apart.

Designed for high bandwidths

High-bandwidth probes are only possible through the use of application-specific integrated circuits (ASIC). Rohde & Schwarz designs these ASICs with particular attention to performance. Low noise, high DC accuracy and minimal drift versus temperature and time are the result. Individual laser trimming of the probes during production results in particularly high accuracy and a very flat frequency response. The design of the contact accessories also permits a high measurement bandwidth for various contacting methods, including manual contacting, solderin and plug-in connections. The compact probe head allows measurements even on densely populated printed boards, and the low weight ensures a minimal load at the contact point.

Minimal influence on the measurement signal

When measuring the high-speed signals used in modern electronic designs, the load from the probe must be kept low. Rohde & Schwarz active probes meet this requirement with 1 M Ω input impedance and an input capacitance of < 1 pF. As a result, the probe's influence on the circuit during measurement is minimized. The optimized design of the probe tips and accessories ensures accurate rise times and minimizes overshoot and ringing.

Rohde & Schwarz active broadband probes with a variety of heads to match the application (e.g. R&S*RT-ZS60/-ZD40: special head design for particularly low input capacitance).





R&S®RT-ZS10/20/30.



R&S®RT-ZD10/20/30



R&S®RT-ZS60.



R&S®RT-ZD40.

Wide dynamic range and high linearity - perfect for spectrum analysis

All Rohde & Schwarz active broadband probes exhibit a wide dynamic range, which is also available at high frequencies. This means that even very fast signals and steep, high-amplitude pulse slopes can be measured. For measurements involving particularly stringent linearity requirements (such as FFT analyses using the R&S®RTO digital oscilloscopes), an excellent choice is the R&S®RT-ZS60 single-ended probe with its exceptionally high linearity (THD -70 dB at 16 V (V_{pp}) at 1 GHz). The optional R&S®RT-ZA9 N(m) adapter allows Rohde & Schwarz broadband probes to be used with spectrum and signal analyzers.

Integrated micro button for convenient instrument control

Measuring with multiple probes often requires a third hand to operate the oscilloscope. The integrated micro button on the probe tip solves this problem. It can be configured on Rohde & Schwarz oscilloscopes to perform a variety of functions, such as run/stop, auto set or save waveform.

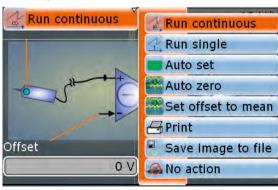
R&S®ProbeMeter: integrated, high-precision voltmeter

The integrated voltmeter is unique to Rohde & Schwarz active probes. It operates independently of the oscilloscope and measures the DC component of a signal with an accuracy of 0.1%. The full dynamic range of the R&S®ProbeMeter is always available, irrespective of the oscilloscope settings. As a result, supply voltages and operating points can be quickly and precisely measured and, with the press of a button, the DC component can be automatically compensated for AC measurements with optimal dynamic range. In the case of differential probes, the DC components of both the differential and the common mode component of the input signal can be measured simultaneously.

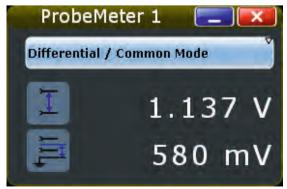
Integrated memory and future-ready probe interface

Rohde & Schwarz active broadband probes have a data memory that is loaded with probe-specific calibration data. This ensures maximum accuracy and allows automatic probe detection. Active probes have a probe interface with a precision BNC-compatible connector that can transmit signals up to 18 GHz. These probes will also work with future Rohde & Schwarz broadband oscilloscopes.

Flexible configuration of the micro button function on the oscilloscope.

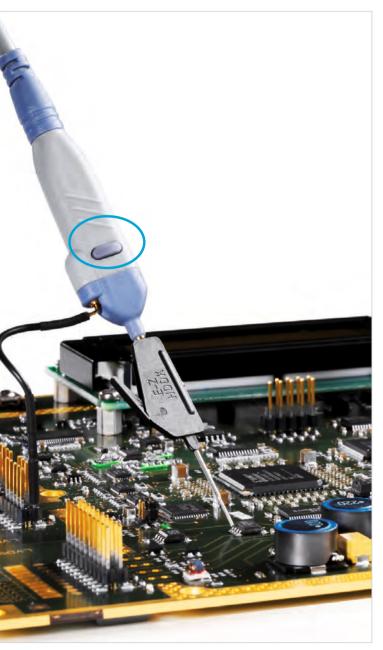


R&S®ProbeMeter: high DC measurement accuracy, independent of the instrument settings and in parallel with the measurement channel.



Single-ended broadband probes

A particularly wide dynamic range, exceptionally low offset and gain errors and the right accessories make these probes the ideal accessory for Rohde & Schwarz oscilloscopes.



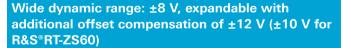
Practical design: micro button for convenient instrument control. Diverse probe tips and ground cables are included as standard.

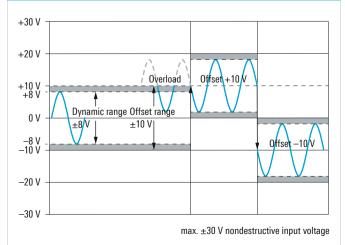
High signal fidelity with active probes

Single-ended active probes are an important accessory for modern broadband oscilloscopes. Rohde & Schwarz offers a variety of models with a maximum bandwidth of 6 GHz. They precisely measure both high-speed and low-frequency signals, for which it is critical that the probe impedance places only a minimal load on the test point. Rohde & Schwarz single-ended active probes feature a high input impedance of 1 M Ω , a low input capacitance down to 0.3 pF and noise of 2 mV (RMS) referenced to the input.

Wide dynamic range with additional offset compensation

In addition to the wide dynamic range of ± 8 V, Rohde & Schwarz single-ended active probes also offer an offset compensation of ± 12 V. As a result, the DC component of the measured signal can be compensated so that the signal components of interest are displayed on the oscilloscope at maximum resolution. The maximum input voltage of 30 V ensures that the probe is not damaged by overloads.





Extensive set of standard accessories for the R&S®RT-ZS60 single-ended probe.



R&S®RT-ZA9 N(m) adapter for active broadband probes for use with signal and spectrum analyzers.



Exceptionally low offset and gain errors, minimal temperature drift

Rohde & Schwarz single-ended active probes are characterized by impressively low offset and gain errors. The minimal gain drift coupled with the offset compensation permits precise measurements – even over extended periods of time and at varying temperatures. Frequent compensation during the measurement is no longer necessary, simplifying everyday measurement tasks.

Accessories for high signal fidelity

All Rohde & Schwarz single-ended active probes come with high-quality accessories. The R&S®RT-ZS60, for example, includes signal and ground solder-in pins and probe tips. Its design enables test point contacting with particularly low input capacitance.

| Model | Bandwidth | Attenuation | | Dynamic | Comment | Order No. |
|--------------|-----------|-------------|----------------|--|---|--------------|
| | | factor | impedance | range | | |
| Probes | | | | | | |
| R&S®RT-ZS10L | 1 GHz | 10:1 | 1 MΩ 0.9 pF | ±8 V | BNC interface , 50 Ω output | 1333.0815.02 |
| R&S®RT-ZS10E | 1.0 GHz | 10:1 | 1 MΩ 0.8 pF | ±8 V | Rohde&Schwarz probe interface | 1418.7007.02 |
| R&S®RT-ZS10 | 1.0 GHz | 10:1 | 1 MΩ 0.8 pF | ±8 V | R&S®ProbeMeter and micro button for | 1410.4080.02 |
| R&S®RT-ZS20 | 1.5 GHz | 10:1 | 1 MΩ 0.8 pF | (±12 V offset | instrument control, Rohde & Schwarz probe interface | 1410.3502.02 |
| R&S®RT-ZS30 | 3.0 GHz | 10:1 | 1 MΩ 0.8 pF | compensation) | interrace | 1410.4309.02 |
| R&S®RT-ZS60 | 6.0 GHz | 10:1 | 1 MΩ 0.3 pF | ±8 V (±10 V offset compensation) | | 1418.7307.02 |
| Accessories | | | | | | |
| R&S®RT-ZA2 | | | | | accessory set for R&S®RT-ZS10/20E/20/30 | 1416.0405.02 |
| R&S®RT-ZA3 | | | | | pin set for R&S®RT-ZS10/10E/20/30 | 1416.0411.02 |
| R&S®RT-ZA4 | | | | | mini clips | 1416.0428.02 |
| R&S®RT-ZA5 | | | | | micro clips | 1416.0434.02 |
| R&S®RT-ZA6 | | | | | lead set | 1416.0440.02 |
| R&S®RT-ZA9 | | | | | N(m) Adapter for R&S®RT-Zxx oscilloscope probes | 1417.0909.02 |

Differential broadband probes

An extremely flat frequency response and a high input impedance with low input capacitance permit precise measurements on differential signals while keeping the loading on the DUT low. The high common mode rejection over the entire probe bandwidth ensures high immunity to interference. Special browser adapters allow flexible contacting with high signal fidelity.

High common mode rejection

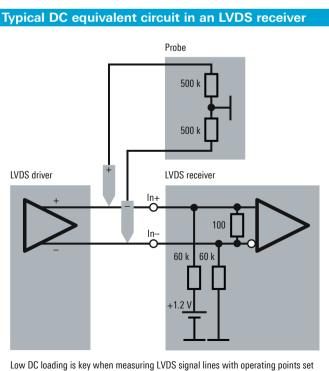
Differential signals are used especially at high clock rates to effectively suppress common mode interference and to transmit broadband signals without errors. These signals can be measured accurately only by using differential probes. Common mode rejection is an important quality parameter. Rohde & Schwarz differential probes suppress common mode interference over the entire probe bandwidth.

Low loading at DC and high frequencies

In the case of DC voltage, a distinction must be made between the input impedance for differential and common mode signals. This is particularly important when measuring low-voltage differential signaling (LVDS) lines, for example. Although the differential input impedance of LVDS receivers is typically $100~\Omega$, the operating point is often set at high impedance. Excessive loading on the signal line can shift the operating point outside of the receiver's input voltage range and impair the functioning of the circuit. Rohde & Schwarz differential probes have a very high differential input impedance of $1~M\Omega$ and a common mode impedance of $250~k\Omega$, ensuring that the loading remains low

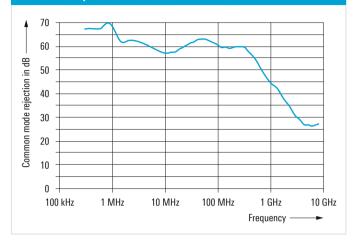
Compact R&S*RT-ZD40 active broadband probe.





Low DC loading is key when measuring LVDS signal lines with operating points set at high impedance

High common mode rejection over the entire probe bandwidth: here the R&S®RT-ZD40



R&S®RT-ZD40: browser adapters to easily vary the pin offset



Wide dynamic range expands the range of applications

The wide dynamic range of ±5 V with an additional offset compensation of ±5 V (differential mode) and ±22 V 1) (common mode) means that Rohde & Schwarz differential broadband probes are universal measurement tools. Highspeed, single-ended signals at DDR storage ports are just as easily measured as symmetrically fed RF signals or voltages without reference to ground in switching power supplies.

The R&S®RT-ZD10 active differential probe, together with the included R&S®RT-ZA15 external attenuator, permits the measurement of voltages up to ±60 V DC/±42.4 V AC (V₂) at a bandwidth of 1 GHz.

Focus on usability

When designing the probe accessories, Rohde&Schwarz paid particular attention to usability. Clear identification of the positive and negative inputs, an extensive array of probe tips, easy and precisely adjustable pin offset and spring-loaded tips for the browser adapters are only a few of the special features.

1) This option is available for the R&S*RT-ZD20/30/40 starting with serial number



| Model | Bandwidth | Attenuation factor | Input impedance | Dynamic range | Comment | Order No. |
|-------------|-----------|--------------------|--------------------|---|--|--------------|
| Probes | | | | | | |
| R&S®RT-ZD10 | 1 GHz | 10:1 | 1 MΩ 0.6 pF | ±5 V, | R&S®ProbeMeter and micro button | 1410.4715.02 |
| R&S®RT-ZD20 | 1.5 GHz | 10:1 | 1 MΩ 0.6 pF | with R&S®RT-ZA15: ±60 V DC/ | for instrument control; | 1410.4409.02 |
| R&S®RT-ZD30 | 3.0 GHz | 10:1 | 1 MΩ 0.6 pF | ±42.4 V AC (peak); offset compensation: ±5 V (differential mode), ±22 V ¹⁾ (common mode) | R&S*RT-ZD10; compensation: (differential a), ±22 V ¹⁾ Rohde & Schwarz probe interface | 1410.4609.02 |
| R&S®RT-ZD40 | 4.5 GHz | | 1 MΩ 0.4 pF | ±5 V | | 1410.5205.02 |
| Accessories | | | | | | |
| R&S®RT-ZA4 | | | | | mini clips | 1416.0428.02 |
| R&S®RT-ZA5 | | | | | micro clips | 1416.0434.02 |
| R&S®RT-ZA6 | | | | | lead set | 1416.0440.02 |
| R&S®RT-ZA7 | | | | | pin set for R&S®RT-ZD10/20/30 | 1417.0609.02 |
| R&S®RT-ZA8 | | | | | pin set for R&S®RT-ZD40 | 1417.0867.02 |
| R&S®RT-ZA15 | 2 GHz | 10:1 | 1 MΩ 1.3 pF | ±60 V DC/ ±42.4 V AC (peak) | external attenuator for R&S°RT-ZD20/30 | 1410.4744.02 |

Modular broadband probes



R&S°RT-ZM probe amplifier module with Rohde&Schwarz probe interface. The amplifier is equipped with a double-socket SMP connector.

Addressing high-speed probing challenges

The R&S®RT-ZM modular probe system addresses today's probing requirements with a technically sophisticated, yet easy-to-handle solution. The various probing solutions meet the demands for high probing bandwidth and dynamic range in conjunction with the need for low capacitive load. Examples include semi-permanent solder-in probe tips for physically small probing areas or a solution for environmental tests in climatic chambers at temperatures from –55°C to +125°C.

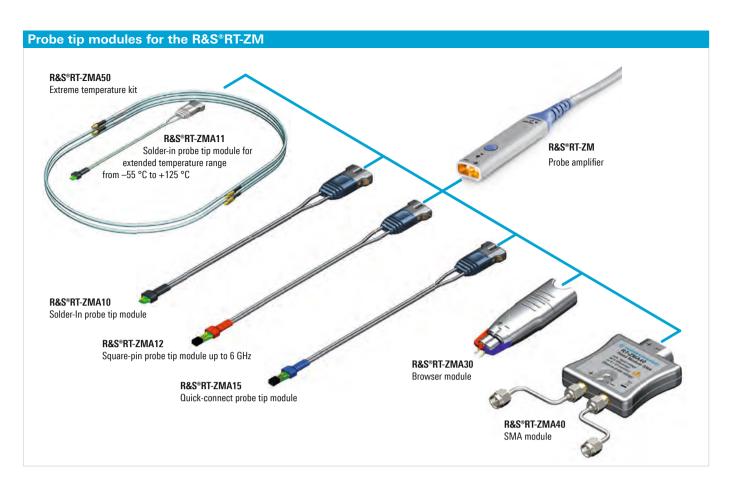
The R&S®RT-ZM modular probe system delivers high performance in combination with flexible and configurable connectivity. The R&S®RT-ZM probe system includes probe tip modules for various measurement tasks and conditions. The probe tip modules can be connected to amplifier modules with bandwidths ranging from 1.5 GHz to 9 GHz. The modular probe system also offers multimode functionality, enabling users to switch between different measurement modes. The integrated R&S®ProbeMeter functionality makes it possible to perform high-precision DC voltage measurements at the same time.

R&S®RT-ZM probe amplifier modules

The R&S®RT-ZM modular probe system is available with amplifier modules offering bandwidths from 1.5 GHz to 9 GHz. The amplifier modules come with a Rohde&Schwarz probe interface that allows automatic probe detection and configuration on Rohde&Schwarz digital oscilloscopes. The amplifier is equipped with a miniaturized high-quality and high-frequency coaxial double-socket SMP connector for flexible snap-on use with various probe tips modules (see figure on next page).

The SMP connector on the amplifier is specially designed for a bandwidth from DC to 26.5 GHz. It offers minimum return loss and ensures high repeatability for many connect/disconnect cycles. The double-socket SMP connector has built-in connector alignment to safeguard the connection between the probe amplifier module and the probe tip modules to provide highly repeatable signal transmission conditions.

Block diagram of the R&S®RT-ZM modular probe system with exchangeable R&S®RT-ZM probe tip module, connected via a high-performance double-socket SMP snap-on interface to an R&S®RT-ZM probe amplifier module with Rohde & Schwarz probe interface. R&S®RT-ZM R&S®RT-ZM amplifier (ASIC) probe amplifier module ±4 V Micro termination Multimode button voltage R&S®RT-ZM DC offset Rohde & Schwarz Interface probe tip SMP compensation probe interface module snap-on R&S®ProbeMeter A/D converter



▶ For detailed information, see R&S®RT-ZM flyer PD 3607.5690.32

| Model | System bandwidth | Rise time (10% to 90%) | Multimode | Comment | Order No. |
|-----------------|------------------|---------------------------|-----------|---|--------------|
| Probe amplifier | modules | | | | |
| R&S®RT-ZM15 | > 1.5 GHz | < 230 ps | | | 1800.4700.02 |
| R&S®RT-ZM30 | > 3 GHz | < 100 ps | | | 1419.3005.02 |
| R&S®RT-ZM60 | > 6 GHz | < 75 ps | | | 1419.3105.02 |
| R&S®RT-ZM90 | > 9 GHz | < 50 ps | | | 1419.3205.02 |
| Probe tip modu | les | | | | |
| R&S®RT-ZMA10 | | | P/N/DM/CM | length: 15 cm (5.9 in) | 1419.4301.02 |
| R&S®RT-ZMA11 | | | P/N/DM/CM | length: 15 cm (5.9 in) | 1419.4318.02 |
| R&S®RT-ZMA12 | | | P/N/DM/CM | length: 15 cm (5.9 in) | 1419.4324.02 |
| R&S®RT-ZMA15 | | | P/N/DM/CM | length: 15 cm (5.9 in) | 1419.4224.02 |
| R&S®RT-ZMA30 | | | DM | | 1419.4353.02 |
| R&S®RT-ZMA40 | | | P/N/DM/CM | 50 $\Omega/100~\Omega$, suitable for SMA, 3.5 mm and 2.92 mm systems, termination voltage $\pm 4~V$, supplied from R&S*RT-ZM probe amplifier module | 1419.4201.02 |
| R&S®RT-ZMA50 | | | P/N/DM/CM | cable length: 1 m (39.37 in); consists of R&S°RT-ZMA11 and a pair of matched extension cables, temperature range: -55°C to +125°C | 1419.4218.02 |
| Probe tip modu | le case | | | | |
| R&S®RT-ZMA1 | | | | for up to 6 R&S®RT-ZMAxx probe tip modules | 1419.3928.02 |
| R&S®RT-ZAP | | | | 3D probe positioner | 1326.3641.02 |

Power rail probe

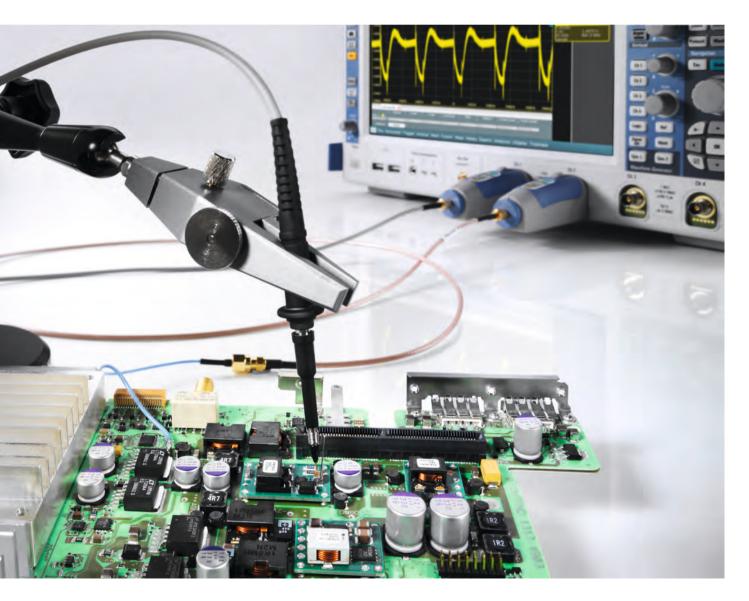
High bandwidth, high sensitivity, very low noise and an extra-large offset compensation make the R&S®RT-ZPR20 an excellent probe for characterizing power rails. An integrated high-accuracy DC voltmeter provides instantaneous DC voltage readout.

2.0 GHz bandwidth and very low added noise

Low voltages with tight tolerances make testing power rails difficult. Not only do newer power rails require more precise low-voltage measurements, but the rails are susceptible to coupling from high-speed clocks and RF sources.

With a bandwidth of 2.0 GHz, excellent sensitivity due to the 1:1 attenuation ratio and low noise, the R&S°RT-ZPR20 excels at precise ripple measurements. Coupled with the industry's best spectrum analysis capabilities of the R&S°RTO2000 and R&S°RTE digital oscilloscopes, the solution additionally helps users isolate periodic and random disturbances (PARD).

The slow frequency rolloff ensures that 2.4 GHz signals are also easily visible with the power rail probe.

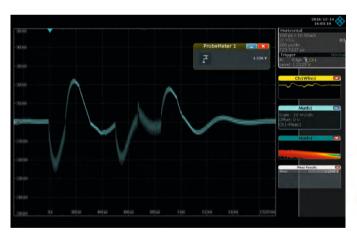


Measuring small voltages riding on large DC offsets

The oscilloscopes' built-in offset is typically not sufficient to zoom in and to accurately measure peak-to-peak voltage on DC power rails. This makes accurate ripple measurements impossible. With $\pm 60~V$ offset compensation range, the R&S*RT-ZPR20 allows users to zoom in on DC voltages with high offset. Whether you need to zoom in on a 1 V power rail or something much higher, the probe provides the needed offset.



The high bandwidth of the R&S*RT-ZPR20 allows you to capture even high-frequency noise components that can be easily analyzed with the R&S*RTO spectrum analysis function.



Accurately verify DC level and power supply load response during initialization of a DDR3 memory with the R&S*ProbeMeter and the R&S*RTO oscilloscope's flexible math functions.

R&S®ProbeMeter – integrated high-accuracy DC voltmeter

While other oscilloscopes are limited to showing a waveform view of power rails under test, the R&S°ZPR20 probe additionally incorporates a high-accuracy DC voltmeter to quickly see rail values. The integrated DC voltmeter with an input voltage range of ± 60 V monitors long-term drift of the DC level with high accuracy. Combined with the ripple voltage observed at the oscilloscope, you can see at any time whether the power supply ripple leaves the permitted operating voltage window of the DUT.

Comprehensive accessories included

The R&S®RT-ZPR20 standardly comes with solder-in cables for broadband probing and a 350 MHz browser kit to easily measure at different places on a PCB or to verify the DC power supply using the R&S®ProbeMeter.



The R&S®RT-ZPR20 comes with a rich set of standard accessories for probing in all scenarios.

| Model | Bandwidth | Attenuation factor | Input impedance | Dynamic range | Comment | Order No. |
|--------------|-----------|--------------------|--------------------|---|---|--------------|
| R&S®RT-ZPR20 | 2.0 GHz | 1:1 | 50 kΩ | ±0.85 V (±60 V offset compensation), optional AC coupling | R&S®ProbeMeter | 1800.5006.02 |
| R&S®RT-ZA25 | _ | _ | _ | _ | power rail browser kit, included with R&S®RT-ZPR20 | 1800.5329.00 |
| R&S®RT-ZA26 | - | _ | _ | - | pigtail cable, 15 cm, solder- in, SMA for R&S®RT-ZPR power rail probe | 1800.5258.00 |

Multi-channel power probe

Power consumption is a major concern in the Internet of things (IoT) world and for a lot of consumer electronics devices. The R&S®RT-ZVC multi-channel power probe offers up to four voltage and four current channels with 18-bit resolution for high dynamic range current and voltage measurements. With up to two R&S®RT-ZVC probes supported on a single R&S®RTE or R&S®RTO oscilloscope, it is possible to analyze eight high dynamic range current signals in parallel with signals captured by the oscilloscope.

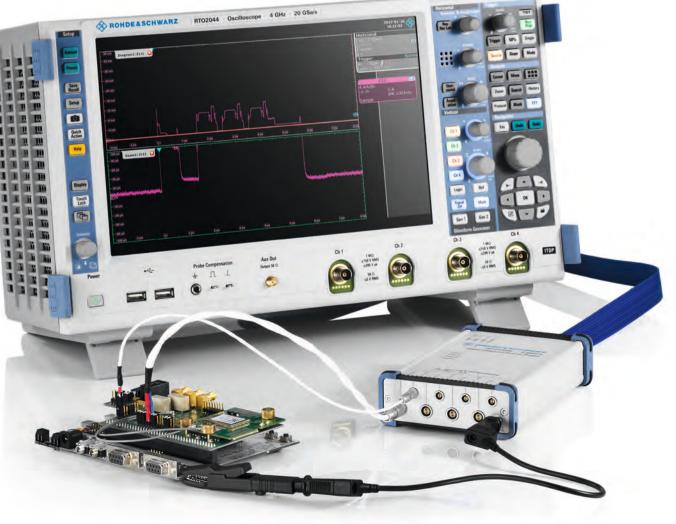
To optimize the battery life of embedded devices, the device's active, sleep and hibernate current consumption needs to be balanced. While active current consumption can reach levels of tens or hundreds of mA, sleep currents are often as low as several μA , but they still significantly influence battery life since devices are in sleep mode most of the time.

Very high dynamic range with 18-bit ADC resolution

With up to four current and four voltage input channels, each with 18-bit ADC resolution, the R&S*RT-ZVC02/-ZVC04 multi-channel power probe provides the dynamic range needed to analyze current consumption in all mobile device activity phases.

Internal and external shunt current measurement with switchable sensitivity

Three built-in shunts and an external shunt mode in combination with switchable gain factors lets you optimize the input current range. Differential inputs provide floating measurements within an input voltage operating window of ± 15 V. Settings are fully controlled from the oscilloscope user interface.

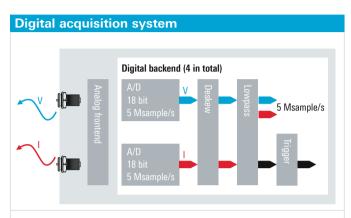


High bandwidth with flexible filtering for noise reduction

A bandwidth of 1 MHz and a sampling rate of 5 Msample/s allows you to capture fast current pulses. To analyze the overall power consumption of battery powered devices, the very low sleep-mode currents have to be captured at the same time. For very high dynamic range measurements, the integrated low-pass filter reduces the bandwidth down to 5 kHz and minimizes overall system noise.

Measure up to eight power rails at the same time with highest accuracy

One R&S®RTE or R&S®RTO digital oscilloscope supports up to two R&S®RT-ZVC current probes so that it is possible to observe eight power domains in parallel with a DC accuracy of 0.1% for voltage measurements and 0.2% for current measurements. Ramp-up processes and power rail tolerances can easily be tested with this probe. The oscilloscope's SCPI remote control enables automatic testing.

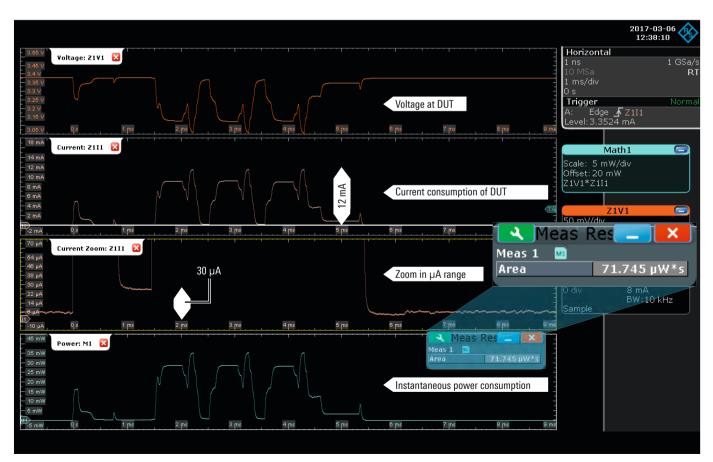


The R&S®RT-ZVC probe's digital acquisition system provides 18-bit resolution, a 5 Msample/s sampling rate and 1 MHz bandwidth. Each voltage and current input pair forms a high dynamic range power measurement system.

| Current ranges | |
|--|----------|
| Low-gain mode | Shunt |
| ±4.5 μA; ±45 μA | 10 kΩ |
| ±4.5 mA; ±45 mA | 10 Ω |
| ±4.5 A; ±10 A | 10 mΩ |
| ±45 mV ¹⁾ ; ±450 mV ¹⁾ | external |

¹⁾ Current range depends on shunt value.

Voltage ranges ∎ ±1.88 V ∎ ±3.75 V ∎ ±7.5 V 1 ±15 V



The R&S®RT-ZVC probe provides an extraordinarily high dynamic range for measuring both active state currents and sleep currents, in this example 12 mA and 30 µA. Automated measurements make it possible to calculate the total energy consumption.

Very low-noise frontend for measuring sensor signals

The extraordinarily high dynamic range and low-noise design of the R&S®RT-ZVC probe enables clear measurement of small sensor signals. Maximum sensitivity can be achieved by using the current inputs in external shunt mode which results in 18-bit resolution at 45 mV full-scale differential input voltage. A cardiac voltage pulse with a signal level of only 200 μV (V_{pp}) can easily be captured and analyzed.

Flexible connectivity options for every application

The R&S®RT-ZVC multi-channel power probe comes with a set of high-quality pin connector cables and solder-in leads to connect the probe in typical embedded electronics measurement scenarios. 4 mm connector cables with different lengths are optionally available as are BNC type connector cables for connecting standard oscilloscope voltage and current probes to extend the voltage and current measurement range.



Small signals such as a 200 μV cardiac pulse can easily be measured.



Standard accessories include PCB connector cables for each channel and solder-in leads.



4 mm cables with different lengths and BNC connector cables are optionally available.

| Model | Input channels | Bandwidth/ sampling rate | Resolution | Input impedance | Full-scale input range | Common mode input voltage range | Order No. |
|--------------|-------------------------|--------------------------------|------------|---|--|--|--------------|
| R&S®RT-ZVC02 | 2 current, 2 voltage | 1 MHz/ 5 Msample/s | 18-bit | Voltage channels: | ■ Voltage ■ ±1.88 V | ±15 V | 1326.0259.02 |
| R&S®RT-ZVC04 | 4 current, 4 voltage | | | 10 MΩ 48 pF I Current channels: 1 MΩ shunt resistor | • $\pm 3.75 \text{ V}$ • $\pm 7.5 \text{ V}$ • $\pm 15 \text{ V}$ • Current (internal shunt) • $10 \text{ k}\Omega$: $\pm 4.5 \text{ µA}$, $\pm 45 \text{ µA}$, $\pm 10 \Omega$: $\pm 4.5 \text{ m}$, $\pm 45 \text{ mA}$, • $10 m\Omega$: $\pm 4.5 \text{ A}$, $\pm 10 \text{ A}$ • Current (external shunt, voltage range) • $\pm 45 \text{ mV}$, $\pm 450 \text{ mV}$ (all channels) | | 1326.0259.04 |

| Accessory | Comment | Order No |
|-------------|---|--------------|
| R&S®RT-ZA30 | Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and 1 voltage lead, length: 32 cm | 1333.1686.02 |
| R&S®RT-ZA31 | Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and 1 voltage lead, length: 32 cm | 1333.1692.02 |
| R&S®RT-ZA33 | Oscilloscope interface cable for R&S®RT-ZVC (included with R&S®RT-ZVC02/-ZVC04, 1326.0259.02/.04) | 1333.1770.02 |
| R&S®RT-ZA34 | Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and 1 voltage lead, length: 1 m | 1333.1892.02 |
| R&S®RT-ZA35 | Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and 1 voltage lead, length: 1 m | 1333.1905.02 |
| R&S®RT-ZA36 | Solder-in cable set for R&S®RT-ZVC, 4 current and voltage solder-in cables, solder-in pins | 1333.1911.02 |
| R&S®RT-ZA37 | Extended cable set for R&S®RT-ZVC, BNC connector, 1 current and 1 voltage lead, length: 16 cm | 1337.9130.02 |
| R&S®RTE-B1E | Digital extension port for R&S®RT-ZVC usage with the R&S®RTE digital oscilloscope (included with R&S®RTE-B1E) | 1333.0750.02 |
| R&S®RTO-B1E | Digital extension port for R&S®RT-ZVC usage with the R&S®RTO digital oscilloscope (included in R&S®RTO-B1E) | 1333.0738.02 |

High-voltage probes

The Rohde & Schwarz portfolio of high-voltage probes includes single-ended and differential probes for root mean square (RMS) voltages up to 1000 V for applications up to measurement category CAT II or CAT III.

High voltages require special safety precautions

Measuring voltages > 33 V (RMS)/46 V (V_p) requires special safety precautions in line with the European Low Voltage Directive. These include protective measures such as protection against accidental contact for all metal parts not connected to protective ground and protection against transient overvoltages through sufficient clearance and creepage distances. The dimensioning of these protective measures determines the measurement category and the field of application for the probe.

Single-ended passive probes for RMS voltages up to 1000 V (CAT II)

Rohde & Schwarz offers two probes for single-ended measurements at high voltages, the R&S®RT-ZH10 and the R&S®RT-ZH11. These differ in their attenuation factors of 100:1 and 1000:1, respectively. The probe with the best attenuation for maximum sensitivity can be

R&S*RT-ZH10 high-voltage, single-ended probe with extensive set of accessories.



Maximum pulse peak voltage as a function of the RMS voltage R&S*RT-ZH10 CAT I A 4000 R 5000 R 5000

CAT II CAT III CAT IV Power supply Coket Coket Company of measurement categories CAT 0 through CAT IV Cat IV Cat IV Transformer The probe design determines its area of application and the maximum rated voltage against protective ground.

selected to match the input voltage being measured. Rohde & Schwarz oscilloscopes automatically detect the attenuation factor.

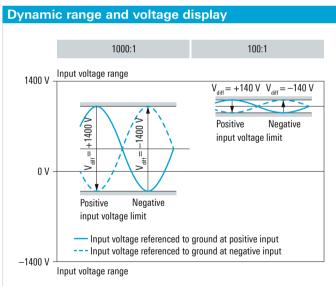
Both probes are designed for RMS voltages up to 1000 V (CAT II) and – when used exclusively for pulse measurements – for peak voltages of up to 6000 V (CAT I). Accessories include safety alligator clips, rigid and spring-loaded tips and protection caps.

High-voltage differential probe for RMS voltages up to 1000 V (CAT III)

Floating measurements are sometimes required during measurements on power electronics. Rohde & Schwarz offers the R&S*RT-ZD01 high-voltage differential probe for measuring RMS voltages up to 1000 V (CAT III). When used with the R&S*RTO and R&S*RTM digital oscilloscopes, this probe can be easily selected from the menu as a predefined probe. Power is supplied via the oscilloscope's USB port.

The R&S®RT-ZD01 has a high input impedance of 8 M Ω and an input capacitance of 3.5 pF, ensuring low loading on the DUT. The selectable attenuation factor of 1:100 or 1:1000 allows optimal matching to the input voltage swing being measured, and also provides maximum vertical resolution on the oscilloscope. The wide common mode dynamic range of ± 1400 V can be used for both attenuation factors.





| Model | Bandwidth | Attenuation factor | Input impedance | Dynamic range | Comment | Order No. |
|-------------------|-----------|------------------------------|--------------------|--------------------|------------------------------------|--------------|
| Passive | | | | 3 | | |
| R&S®RT-ZH03 | 250 MHz | 100:1 | 100 MΩ 6.5 pF | 850 V (RMS) | | 1333.0873.02 |
| R&S®RT-ZH10 | 400 MHz | 100:1 | 50 MΩ 7.5 pF | 1 kV (RMS) | 1 kV (RMS) (CAT II) | 1409.7720.02 |
| R&S®RT-ZH11 | 400 MHz | 1000:1 | 50 MΩ 7.5 pF | 1 kV (RMS) | 1 kV (RMS) (CAT II) | 1409.7737.02 |
| Active, different | ial | | | | | |
| R&S®RT-ZD02 | 200 MHz | 10:1 | 1 MΩ 3.5 pF | ±20 V | BNC interface , 50 Ω output | 1333.0821.02 |
| R&S®RT-ZD08 | 800 MHz | 10:1 | 200 kΩ 1 pF | ±15 V | BNC interface , 50 Ω output | 1333.0838.02 |
| R&S®RT-ZD01 | 100 MHz | 100:1/1000:1 (selectable) | 8 MΩ 3.5 pF | ±140 V/ ±1400 V | 1 kV (RMS) (CAT III) | 1422.0703.02 |

Current probes

Rohde & Schwarz current probes are available in different versions: compact, battery-operated probes for industrial applications to measure currents up to 1000 A and high-precision probes for lab applications, with bandwidths up to 120 MHz and a sensitivity of 1 V/A.

DC and AC measurements without circuit interruption

The R&S°RT-ZC10 and the R&S°RT-ZC20 current probes precisely measure direct and alternating current without interrupting the power circuit for the measurement. The extra-large opening on the R&S°RT-ZC10 accommodates conductors of up to 20 mm in diameter. The R&S°RT-ZC10 can measure peak currents up to 300 A (500 A for a single pulse). When measuring low-amplitude, high-frequency currents, the more compact R&S°RT-ZC20 with a measurement bandwidth of 100 MHz is ideal.

Robust design and easy operation

Rohde & Schwarz current probes are characterized by their robust design and easy operation. The degauss and offset correction is easily performed directly at the probe connector. The compact R&S®RT-ZA13 probe power supply supplies up to four current probes. The current probes can be selected as predefined probes on the R&S®RTO and R&S®RTM digital oscilloscopes.

R&S*RT-ZC20B current probe with Rohde & Schwarz probe interface (100 MHz, 30 A (RMS)).



External power supply for up to four current probes.



Easy deskewing for simultaneous current and voltage measurements

For meaningful measurements on power electronics, there must be no time delay (skew) between the current and the voltage measurements. The R&S®RT-ZF20 power deskew and calibration test fixture provides a variety of test signals that can be used to easily compensate for the skew between Rohde & Schwarz current and voltage probes. Power to the power deskew and calibration test fixture is supplied via the oscilloscope's USB port.

R&S®RT-ZF20 power deskew and calibration test fixture: easy deskewing for measurements on power electronics.



| Model | Bandwidth | Sensitivity | Dynamic range | Rise time | Comment | Order No. |
|--------------|-----------|------------------------|---|-----------|---|--------------|
| Probes | | | | | | |
| R&S®RT-ZC02 | 20 kHz | 0.01 V/A, 0.001 V/A | ±200 A, ±2000 A | 5 μs | battery powered | 1333.0850.02 |
| R&S®RT-ZC03 | 100 kHz | 0.1 V/A | ±30 A | 1 µs | battery powered | 1333.0844.02 |
| R&S®RT-ZC05B | 2 MHz | 0.01 V/A | 500 A (RMS), 700 A (peak) | 175 ns | power supply via Rohde&Schwarz probe interface | 1409.8204.02 |
| R&S®RT-ZC10 | 10 MHz | 0.01 V/A | 150 A (RMS) | 35 ns | power supply via R&S®RT-ZA13 | 1409.7750K02 |
| R&S®RT-ZC10B | 10 MHz | 0.01 V/A | ±300 A (peak), ±500 A (peak) (single pulse) | 35 ns | power supply via Rohde&Schwarz probe interface | 1409.8210.02 |
| R&S®RT-ZC15B | 50 MHz | 0.1 V/A | 30 A (RMS) ±50 A (peak) | 7 ns | power supply via Rohde&Schwarz probe interface | 1409.8227.02 |
| R&S®RT-ZC20 | 100 MHz | 0.1 V/A | | 3.5 ns | power supply via R&S®RT-ZA13 | 1409.7766K02 |
| R&S®RT-ZC20B | 100 MHz | 0.1 V/A | | 3.5 ns | power supply via Rohde&Schwarz probe interface | 1409.8233.02 |
| R&S®RT-ZC30 | 120 MHz | 1 V/A | 5 A (RMS) 7.5 A (peak) | 2.9 ns | power supply via R&S®RT-ZA13 | 1409.7772K02 |
| Accessories | | | | | | |
| R&S®RT-ZF20 | | | | | power deskew and calibration test fixture | 1800.0004.02 |
| R&S®RT-ZA13 | | | | | external power supply for up to four Rohde&Schwarz current probes | 1409.7789.02 |

EMC near-field probes

Powerful E and H near-field probes for the frequency range from 9 kHz to 3 GHz with optional preamplifier expand the application range of the R&S®RTO digital oscilloscopes to include EMI debugging.

R&S®RTO digital oscilloscope's powerful FFT analysis function

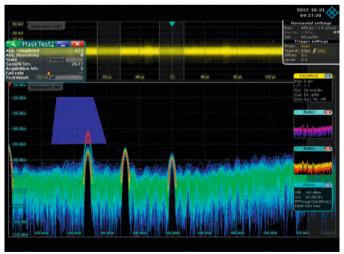
The R&S®RTO digital oscilloscope's powerful FFT function permits for the first time debugging of EMI problems using an oscilloscope. Developers now have a cost-effective solution for EMI debugging right on their lab bench. Unwanted EMI can be displayed simultaneously in both the time and frequency domain, speeding up debugging.

Versatile near-field probe sets

Near-field probes are a tool used to analyze EMC problems in electronic circuits and to identify their causes. Rohde & Schwarz offers the versatile R&S®HZ-15 near-field probe set that includes E-field and H-field probes for use with oscilloscopes, signal and spectrum analyzers and EMI test receivers.

The R&S°HZ-15 passive probe set is the right choice for diagnosing EMC problems on printed boards. Designed for a frequency range of 30 MHz to 3 GHz, the R&S°HZ-15 permits the detection of EMI < 30 MHz at reduced sensitivity. The compact design facilitates localization of EMI sources down to the individual conductors. The optional R&S°HZ-16 preamplifier offers 20 dB gain for greater sensitivity in the frequency range from 100 kHz to 1 GHz.

Direct acquisition and analysis of sporadically occurring EMI thanks to the R&S*RTO digital oscilloscope's powerful spectrum analysis function.



| Model | Frequency range | Comment | Order No. |
|------------------|------------------|--|--------------|
| Near-field probe | | | |
| R&S®HZ-15 | 30 MHz to 3 GHz | compact E and H near-field probe set | 1147.2736.02 |
| Accessories | | | |
| R&S®HZ-16 | 100 kHz to 3 GHz | preamplifier 3 GHz, 20 dB, power adapter 100 V to 230 V | 1147.2720.02 |

Ordering information

| Designation | Туре | Order No. |
|--|----------------|--------------|
| Passive probes | | |
| 38 MHz, passive, 1:1, 1 MΩ, 39 pF, 55 V (RMS), CAT II | R&S®RT-ZP1X | 1333.1370.02 |
| 300 MHz/10 MHz, passive, 10:1/1:1, 10 M Ω /1 M Ω , 5 mm tip, no probe detection | R&S®RT-ZP03 | 3622.2817.02 |
| 500 MHz, passive, 10:1, 10 MΩ, 5 mm tip | R&S®RT-ZP05 | 3623.2927.02 |
| 500 MHz, passive, 10:1, 10 MΩ, 400 V (RMS) | R&S®RT-ZP10 | 1409.7550.00 |
| 500 MHz, passive, 10:1, 10 MΩ, 400 V (RMS) | R&S®RTM-ZP10 | 1409.7708.02 |
| Passive broadband probes | | |
| 8.0 GHz, passive, Z0, 10:1, 500 Ω, 20 V (RMS) | R&S®RT-ZZ80 | 1409.7608.02 |
| Active broadband probes: single-ended | | |
| 1.0 GHz, 10:1, 1 MΩ, BNC interface | R&S®RT-ZS10L | 1333.0815.02 |
| 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface | R&S®RT-ZS10E | 1418.7007.02 |
| 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde &Schwarz probe interface | R&S®RT-ZS10 | 1410.4080.02 |
| 1.5 GHz, active, 1 MΩ, R&S°ProbeMeter, micro button, Rohde &Schwarz probe interface | R&S®RT-ZS20 | 1410.3502.02 |
| 3.0 GHz, active, 1 MΩ, R&S°ProbeMeter, micro button, Rohde &Schwarz probe interface | R&S®RT-ZS30 | 1410.4309.02 |
| 6.0 GHz, active, 1 MΩ, R&S°ProbeMeter, micro button, Rohde &Schwarz probe interface | R&S®RT-7S60 | 1418.7307.02 |
| Active broadband probes: differential | 11005 111 2500 | 1410.7307.02 |
| 1.0 GHz, active, differential, 1 MΩ, R&S*ProbeMeter, micro button, including 10:1 external | R&S®RT-ZD10 | 1410.4715.02 |
| attenuator, 1 M Ω , 70 V DC, 46 V AC (peak), Rohde & Schwarz probe interface | nas ni-ZDIU | 1410.4715.02 |
| 1.5 GHz, active, differential, 1 MΩ, R&S°ProbeMeter, micro button, Rohde & Schwarz probe interface | R&S®RT-ZD20 | 1410.4409.02 |
| 3.0 GHz, active, differential, 1 MΩ, R&S°ProbeMeter, micro button, Rohde & Schwarz probe interface | R&S®RT-ZD30 | 1410.4609.02 |
| 4.5 GHz, active, differential, 1 MΩ, R&S°ProbeMeter, micro button, Rohde & Schwarz probe interface | R&S®RT-ZD40 | 1410.5205.02 |
| Modular broadband probes | | |
| Probe Amplifier Module, 1.5 GHz, 10:1 or 2:1, 400 k Ω (differential mode), 200 k Ω (single-ended mode) | R&S®RT-ZM15 | 1800.4700.02 |
| Probe Amplifier Module, 3 GHz, 10:1 or 2:1, 400 kΩ (differential mode), 200 kΩ (single-ended mode) | R&S®RT-ZM30 | 1419.3005.02 |
| Probe Amplifier Module, 6 GHz, 10:1 or 2:1, 400 kΩ (differential mode), 200 kΩ (single-ended mode) | R&S®RT-ZM60 | 1419.3105.02 |
| Probe Amplifier Module, 9 GHz, 10:1 or 2:1, 400 kΩ (differential mode), 200 kΩ (single-ended mode) | R&S®RT-ZM90 | 1419.3205.02 |
| Power rail probe | | |
| 2.0 GHz, 1:1, 50 k Ω , ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface | R&S®RT-ZPR20 | 1800.5006.02 |
| Power Rail Browser Kit, included with R&S®RT-ZPR20 | R&S®RT-ZA25 | 1800.5329.00 |
| Pigtail Cable, 15 cm, solder-in, SMA for R&S®RT-ZPR20 | R&S®RT-ZA26 | 1800.5258.00 |
| Multi-channel power probe | | |
| 1 MHz, 5 Msample/s, 2 × voltage, 2 × current | R&S®RT-ZVC02 | 1326.0259.02 |
| 1 MHz, 5 Msample/s, 4 × voltage, 4 × current | R&S®RT-ZVC04 | 1326.0259.04 |
| High-voltage probes: single-ended | | |
| 250 MHz, 100:1, 100 MΩ, 850 V (RMS) | R&S®RT-ZH03 | 1333.0873.02 |
| 400 MHz, passive, high-voltage, 100:1, 50 MΩ, 1 kV (RMS) (CAT II) | R&S®RT-ZH10 | 1409.7720.02 |
| 400 MHz, passive, high-voltage, 1000:1, 50 MΩ, 1 kV (RMS) (CAT II) | R&S®RT-ZH11 | 1409.7737.02 |
| High-voltage probes: differential | | |
| 100 MHz, high-voltage, active, differential, 8 MΩ, 1 kV (RMS) (CAT III) | R&S®RT-ZD01 | 1422.0703.02 |
| 200 MHz, 10:1, BNC interface, ±20 V | R&S®RT-ZD02 | 1333.0821.02 |
| 800 MHz, 10:1, 200 kΩ, BNC interface, ±15 V | R&S®RT-ZD08 | 1333.0838.02 |
| Current probes | 1100 111 2200 | 1000.0000.02 |
| 20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A | R&S®RT-ZC02 | 1333.0850.02 |
| 100 kHz, AC/DC, 0.01 V/A, 30 A | R&S®RT-ZC03 | 1333.0844.02 |
| 2 MHz, AC/DC, 0.01 V/A, 500 A (RMS) | R&S®RT-ZC05B | 1409.8204.02 |
| 10 MHz, AC/DC, 0.01 V/A, 150 A (RMS) | R&S®RT-ZC10 | 1409.7750K02 |
| 100 MHz, AC/DC, 0.01 V/A, 100 A (RMS) | R&S®RT-ZC20 | 1409.7766K02 |
| 120 MHz, AC/DC, 1 V/A, 50 A (RMS) | R&S®RT-ZC30 | 1409.7770K02 |
| | | |
| 10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe interface | R&S®RT-ZC10B | 1409.8210.02 |
| 50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface | R&S®RT-ZC15B | 1409.8227.02 |
| 100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde&Schwarz probe interface | R&S®RT-ZC20B | 1409.8233.02 |

| Designation | Туре | Order No. |
|--|--------------|--------------|
| EMC near-field probes | | |
| Compact Probe Set for E and H Near-Field Measurements, 30 MHz to 3 GHz | R&S®HZ-15 | 1147.2736.02 |
| Logic probes (included with R&S®RTx-B1 mixed signal oscilloscope options) | | |
| 300 MHz Logic Probe, 8 channels | R&S®RT-ZL03 | 1333.0715.02 |
| 400 MHz Logic Probe, 8 channels | R&S®RT-ZL04 | 1333.0721.02 |
| Probe accessories | | |
| Accessory Set for R&S°RT-ZP10 passive probe (2.5 mm probe tip) | R&S®RT-ZA1 | 1409.7566.00 |
| Spare Accessory Set for R&S®RT-ZS10/10E/20/30 | R&S®RT-ZA2 | 1416.0405.02 |
| Pin Set for R&S®RT-ZS10/10E/20/30 | R&S®RT-ZA3 | 1416.0411.02 |
| Mini Clips | R&S®RT-ZA4 | 1416.0428.02 |
| Micro Clips | R&S®RT-ZA5 | 1416.0434.02 |
| Lead Set | R&S®RT-ZA6 | 1416.0440.02 |
| Pin Set for R&S®RT-ZD10/20/30 | R&S®RT-ZA7 | 1417.0609.02 |
| Pin Set for R&S®RT-ZD40 | R&S®RT-ZA8 | 1417.0867.02 |
| N(m) Adapter for R&S®RT-Zxx oscilloscope probes | R&S®RT-ZA9 | 1417.0909.02 |
| SMA Adapter | R&S®RT-ZA10 | 1416.0457.02 |
| Probe Power Supply | R&S®RT-ZA13 | 1409.7789.02 |
| External Attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC, 42.4 V AC (peak) for R&S®RT-ZD20/30 probes | R&S®RT-ZA15 | 1410.4744.02 |
| Power Deskew and Calibration Test Fixture | R&S®RT-ZF20 | 1800.0004.02 |
| 3 GHz, 20 dB Preamplifier, 100 V to 230 V Power Adapter, for R&S®HZ-15 | R&S®HZ-16 | 1147.2720.02 |
| For R&S®RT-ZM probe amplifier module | | |
| Solder-In Probe Tip Module | R&S®RT-ZMA10 | 1419.4301.02 |
| Solder-In Probe Tip Module for extended temperature range from –55 °C to +125 °C | R&S®RT-ZMA11 | 1419.4318.02 |
| Square-Pin Probe Tip Module up to 6 GHz | R&S®RT-ZMA12 | 1419.4324.02 |
| Quick-Connect Probe Tip Module | R&S®RT-ZMA15 | 1419.4224.02 |
| Browser Module | R&S®RT-ZMA30 | 1419.4353.02 |
| SMA Module | R&S®RT-ZMA40 | 1419.4201.02 |
| Extreme Temperature Kit | R&S®RT-ZMA50 | 1419.4218.02 |
| Probe Tip Module Case for up to 6 R&S®RT-ZMAxx probe tip modules | R&S®RT-ZMA1 | 1419.3928.02 |
| 3D Positioner with central tensioning knob for easy clamping and positioning of probes (span width: 200 mm, clamping range: 15 mm) | R&S®RT-ZAP | 1326.3641.02 |
| Accessories | | |
| Probe Pouch for R&S®RTO/RTE digital oscilloscopes | R&S®RTO-Z5 | 1317.7031.02 |
| Extended Cable Set for R&S®RT-ZVC, PCB probing, 1 current and 1 voltage lead, length: 32 cm | R&S®RT-ZA30 | 1333.1686.02 |
| Extended Cable Set for R&S®RT-ZVC, 4 mm probing, 1 current and 1 voltage lead, length: 32 cm | R&S®RT-ZA31 | 1333.1692.02 |
| Oscilloscope Interface Cable for R&S®RT-ZVC (included with R&S®RT-ZVC02/-ZVC04, 1326.0259.02/.04) | R&S®RT-ZA33 | 1333.1770.02 |
| Extended Cable Set for R&S°RT-ZVC, 4 mm probing, 1 current and 1 voltage lead, length: 1 m | R&S®RT-ZA34 | 1333.1892.02 |
| Extended Cable Set for R&S®RT-ZVC, PCB probing, 1 current and 1 voltage lead, length: 1 m | R&S®RT-ZA35 | 1333.1905.02 |
| Solder-in Cable Set for R&S®RT-ZVC, 4 current and voltage solder-in cables, solder-in pins | R&S®RT-ZA36 | 1333.1911.02 |
| Extended Cable Set for R&S®RT-ZVC, BNC connector, 1 current and 1 voltage lead, length: 16 cm | R&S®RT-ZA37 | 1337.9130.02 |
| Digital Extension Port for R&S®RT-ZVC usage with the R&S®RTE digital oscilloscope (included with R&S®RTE-B1E) | R&S®RTE-B1E | 1333.0750.02 |
| Digital Extension Port for R&S°RT-ZVC usage with the R&S°RTO digital oscilloscope (included with R&S°RTO-B1E) | R&S®RTO-B1E | 1333.0738.02 |

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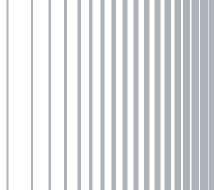
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Probes and accessories

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